

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST
CERTIFICATES FOR ELECTRICAL EQUIPMENT
(IECEE) CB SCHEME

SYSTEME CEI D'ACCEPTATION MUTUELLE DE
CERTIFICATS D'ESSAIS DES EQUIPEMENTS
ELECTRIQUES (IECEE) METHODE OC

CB TEST CERTIFICATE**CERTIFICAT D'ESSAI OC**

Product
Produit

PC motherboards

Name and address of the applicant
Nom et adresse du demandeur

INTEL CORPORATION
2200 MISSION COLLEGE BLVD SANTA CLARA, CA 95054-1537
USA

Name and address of the manufacturer
Nom et adresse du fabricant

INTEL CORPORATION
2200 MISSION COLLEGE BLVD SANTA CLARA, CA 95054-1537
USA

Name and address of the factory
Nom et adresse de l'usine

MAINTEK COMPUTER (SUZHOU) CO LTD
BLDG 6 NB 233 JIN FENG RD SUZHOU JIANGSU 215008
CHINA

Note: When more than one factory, please report on page 2
Note: Lorsque il y plus d'une usine, veuillez utiliser la 2^{ème} page

Additional Information on page 2

Ratings and principal characteristics
Valeurs nominales et caractéristiques principales

Electrical ratings not required (the equipment intended for building-in, supplied by SELV)

Trademark (if any)
Marque de fabrique (si elle existe)



Type of Manufacturer's Testing Laboratories used
Type de programme du laboratoire d'essais constructeur

Model / Type Ref.
Ref. De type

xNUC6xAYBx, xNUC7xBNBx
See Page 2

Additional information (if necessary may also be reported on page 2)
Les informations complémentaires (si nécessaire,, peuvent être indiqués sur la 2^{ème} page

Additionally evaluated to EN 60950-1:2006 /A11:2009 /A1:2010 /A12:2011 /A2:2013; National Differences specified in the CB Test Report.

Additional Information on page 2

A sample of the product was tested and found to be in conformity with
Un échantillon de ce produit a été essayé et a été considéré conforme à la

IEC 60950-1(ed.2), IEC 60950-1(ed.2);am1, IEC 60950-1(ed.2);am2

As shown in the Test Report Ref. No. which forms part of this Certificate
Comme indiqué dans le Rapport d'essais numéro de référence qui constitue partie de ce Certificat

ATTCB105054-02 issued on 2017-03-15

This CB Test Certificate is issued by the National Certification Body

Ce Certificat d'essai OC est établi par l'Organisme **National de Certification**



- UL (US), 333 Ppingsten Rd IL 60062, Northbrook, USA
- UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK
- UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN
- UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

Date: 2017-03-15
Original Issue Date: 2016-10-27

Signature:

Jan-Erik Storgaard

For full legal entity names see www.ul.com/ncbnames



Ref. Certif. No.

DK-58942-A2-UL

Model Details:

xNUC6xAyBx,xNUC7xBNBx (where x may be a combination of alphanumeric characters or blank)

Factories:

GOLDEN ELITE TECHNOLOGY (SHEN ZHEN) LTD
1 NAN HUAN RD SHAJING BAO AN SHENZHEN GUANGDONG 518104
CHINA

Additional Information:

The original report was modified to include the following changes/additions:
Alternate components.

Additional information (if necessary)

Information complémentaire (si nécessaire)



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